Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/750,013	SCHMIDT ET AL.
Examiner	Art Unit
Chun-Kuan (Mike) Lee	2181

	SEAR	CHED	
Class	Subclass	Date	Examiner
710	29	12/13/2005	CHUN- KUAN Lee
710	52-53	12/13/2005	ŀ
710	55	12/13/2005	
710	60	12/13/2005	1
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
serial and FIFO and buffer\$2 and pointer\$2 and (detect\$4 or monitor\$4) and flag\$2 and elastic	12/13/2005	CHUN- KUAN Lee	
serial and (FIFO same pointer\$2) and (detect\$4 or monitor\$4) and elastic	12/13/2005		
serial and (FIFO) and (detect\$4 or monitor\$4) and elastic and ((skip\$4 or jump\$2) same pointer\$2)	12/13/2005		
fifo\$2 and pointer\$2 and overflow\$3 and underflow and ((drop\$4 or skip\$4) same overflow\$3)	12/13/2005		
FIFO\$2 and (((detect\$4 or monitor\$4)) same flag\$2)	12/13/2005		